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Docket No.: 60188-448

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

: Customer Number: 20277

Keiichi FUJIMOTO, et al.

: Confirmation Number: 2785

Serial No.: 09/964,480V

: Group Art Unit: 2829

: Allowed: December 02, 2003

Filed: September 28, 2001

: Examiner: Patel

For: SEMICONDUCTOR INTEGRATED CIRCUIT TESTING SYSTEM AND
METHOD

REQUEST FOR ACKNOWLEDGEMENT OF THE CITED ART

Mail Stop Issue Fee
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

We are in receipt of the Notice of Allowance dated December 02, 2003.

In reviewing the file, it is noted that we have not received acknowledgement of the Information Disclosure Statement and cited art filed November 12, 2003. Enclosed are copies of the Information Disclosure Statement, PTO-1449 and stamped return postcard acknowledgement.

Applicants hereby respectfully requests that:

the appropriately acknowledged PTO-1449 be furnished to Applicants; and

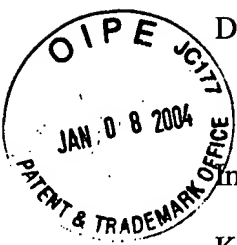
the record be clarified to confirm that the cited art has been considered and made of record.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

Michael E. Fogarty
Registration No. 36,139

600 13th Street, N.W.
Washington, DC 20005-3096
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Facsimile: (202) 756-8087
Date: January 8, 2004



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In re Application of	:	Customer Number: 20277
Keiichi FUJIMOTO, et al.	:	Confirmation Number: 2785
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	:	Examiner: Patel
For: SEMICONDUCTOR INTEGRATED CIRCUIT TESTING SYSTEM AND METHOD	:	

LETTER SUBMITTING FORMAL DRAWINGS

Mail Stop Issue Fee
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In response to the Notice of Allowability dated December 02, 2003, submitted herewith are nine (09) sheets of Formal Drawings in connection with the above referenced application.

Respectfully submitted,

MCDERMOTT, WILL & EMERY


Michael E. Fogarty
Registration No. 36,139

600 13th Street, N.W.
Washington, DC 20005-3096
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Date: January 8, 2004

Applicant: Keiichi FUJIMOTO, et al.Docket No. 60188-448Title: SEMICONDUCTOR INTEGRATED CIRCUIT TESTING SYSTEM AND METHODSerial/Reg./Patent No. 09/964,480Date Sent: 11/12/2003 ☒ Hand Carried ☐ Fax ☐ Electronic ☐ Cert. of Mailing ☐ Express Mail No. _____☒ Transmittal LetterNew Patent App ☐ Utility ☐ Design ☐ Cont. ☐ CIP ☐ Div. ☐ PCT ☐ RCE ☐ Prov☐ Other: _____

_____ pages of Specification

_____ pages of Claims

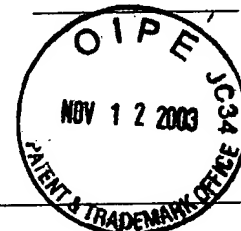
_____ pages of Abstract

_____ pages of Formal/Informal Drawings

☐ Small Entity ☐ Large Entity☐ Declaration/Power of Attorney☐ Recordation of Assignment/Security Agreement☒ Information Disclosure Statement

1 Form PTO 1449

2 copies of cited references

☐ Preliminary Amendment☐ Response to Missing Parts Notice☐ Resp. to Notice to Correct App. Papers☐ Certified Copy of Priority Doc.☐ Claim for Convention Priority☐ Response/Amendment to Office Action of _____☐ Request for _____ month Extension of Time☐ Letter submitting _____ pages of drawings☐ Req. for Approval of Drawing Amendments☐ Req. for Oral Hearing☐ Not. of Appeal ☐ Appeal Brief ☐ Reply Brief☐ Rule 312 Amendment/Letter☐ Req. for Acknowledgement of Cited Art☐ Issue Fee☐ Publication Fee☐ Req. for Certificate of Correction☐ Maintenance Fee for _____ years after grant☐ Fee Address Indication Form☐ Terminal Disclaimer☐ Petition to Commissioner☐ Status Inquiry☒ Other Office Action

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CMS Descrip.: _____

THE PATENT AND TRADEMARK OFFICE DATE STAMPED HEREON IS ACKNOWLEDGEMENT THAT THE ITEMS, CHECKED ABOVE, WERE RECEIVED BY THE PTO ON THE DATE STAMPED.

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